

An Energy Efficient Solution by Freescale

Document Number: MMA7660FC Rev 8, 03/2012

√RoHS

## 3-Axis Orientation/Motion Detection Sensor

The MMA7660FC is a  $\pm 1.5$  g 3-Axis Accelerometer with Digital Output (I<sup>2</sup>C). It is a very low power, low profile capacitive MEMS sensor featuring a low pass filter, compensation for 0g offset and gain errors, and conversion to 6-bit digital values at a user configurable samples per second. The device can be used for sensor data <u>changes</u>, product orientation, and gesture detection through an interrupt pin (INT). The device is housed in a small 3mm x 3mm x 0.9mm DFN package.

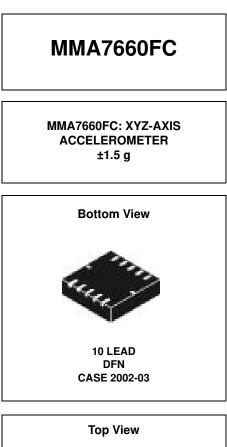
## Features

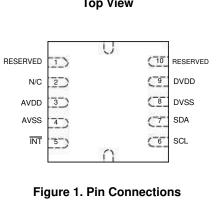
- Digital Output (I<sup>2</sup>C)
- 3mm x 3mm x 0.9mm DFN Package
- Low Power Current Consumption: Off Mode: 0.4 μA, Standby Mode: 2 μA, Active Mode: 47 μA at 1 ODR
- Configurable Samples per Second from 1 to 120 samples a second.
- Low Voltage Operation:
  - Analog Voltage: 2.4 V 3.6 V
  - Digital Voltage: 1.71 V 3.6 V
- Auto-Wake/Sleep Feature for Low Power Consumption
- Tilt Orientation Detection for Portrait/Landscape Capability
- Gesture Detection Including Shake Detection and Tap Detection
- Robust Design, High Shocks Survivability (10,000 g)
- RoHS Compliant
- Halogen Free
- Environmentally Preferred Product
- Low Cost

## **Typical Applications**

- Mobile Phone/ PMP/PDA: Orientation Detection (Portrait/Landscape), Image Stability, Text Scroll, Motion Dialing, Tap to Mute
- Laptop PC: Anti-Theft
- Gaming: Motion Detection, Auto-Wake/Sleep For Low Power Consumption
- Digital Still Camera: Image Stability

| ORDERING INFORMATION                           |              |        |                |  |  |
|--|--------------|--------|----------------|--|--|
| Part Number Temperature Range Package Shipping |              |        |                |  |  |
| MMA7660FCT                                     | -40 to +85°C | DFN-10 | Tray           |  |  |
| MMA7660FCR1                                    | –40 to +85°C | DFN-10 | 7" Tape & Reel |  |  |







© 2009-2012 Freescale Semiconductor, Inc. All rights reserved.

# Contents

| DEFINITIONS  | 5  |
|--|----|
| ELECTRO STATIC DISCHARGE (ESD)   | 7  |
| PRINCIPLE OF OPERATION   | 9  |
| MODES OF OPERATION   | 10 |
| CONFIGURABLE SAMPLES PER SECONDS AND INTERRUPT SETTINGS                          | 11 |
| POWER SAVING FEATURES  | 11 |
| TESTING THE LOGIC CHAIN  | 11 |
| FEATURES   | 11 |
| Tap Detection  | 13 |
| Shake Detection  | 13 |
| Auto-Wake/Sleep  | -  |
| REGISTER DEFINITIONS   |    |
| SERIAL INTERFACE   |    |
| Serial-Addressing  |    |
| Start and Stop Conditions  |    |
| Bit Transfer   |    |
| Acknowledge  |    |
| The Slave Address  |    |
| Message Format for Writing MMA7660FC   |    |
| Message Format for Reading MMA7660FC   |    |
| APPENDIX A - PACKAGE REQUIREMENTS FOR MMA7660FC                                  |    |
| Minimum Recommended Footprint for Surface Mounted Applications                   |    |
| Soldering And Mounting Guidelines for the DFN Accelerometer Sensor to a PC Board |    |
| Overview of Soldering Considerations   |    |
| Halogen Content  |    |
| PCB Mounting Recommendations   |    |
| APPENDIX B - SENSING DIRECTION   |    |
| APPENDIX C - MMA7660FC ACQUISITION CODE TABLE                                    |    |
| APPENDIX D - I <sup>2</sup> C AC CHARACTERISTICS                                 | 30 |



# List of Tables

| Pin Description  |
|--|
| Maximum Ratings  |
| ESD And Latch-up Protection Characteristics                |
| Operating Characteristics                                  |
| Modes Of Operation   |
| Feature Summary Table                                      |
| Orientation Detection Logic of when Interrupt will Occur12 |
| Auto-Wake/Sleep Truth Table                                |
| User Register Summary                                      |
| Modes  |
| ASE/AWE Conditions   |
| Sleep Counter Timeout Ranges                               |
| I <sup>2</sup> C AC Characteristics                        |

# List of Figures

NP

| <sup>2</sup> C Connection to MCU                                  | 6    |
|---|------|
| Simplified Accelerometer Functional Block Diagram                 | 7    |
| Simplified Transducer Physical Model                              | 9    |
| State Machine of Modes  | . 10 |
| Orientation Detection Logic in 3-Dimensional Space                | . 12 |
| 2-Wire Serial Interface Timing Details                            | . 22 |
| Start and Stop Conditions   | . 22 |
| Bit Transfer  |      |
| Acknowledge   |      |
| Slave Address   |      |
| Single Byte Write   | . 23 |
| Multiple Bytes Write  | . 24 |
| Single Byte Read  | . 24 |
| Multiple Bytes Read   | . 24 |
| Package Footprint, PCB Land Pattern, and Stencil Design           |      |
| PCB Land Pattern Detail   |      |
| Product Orientation on Perpendicular Axis                         |      |
| Product Orientations Showing Direction for Each Axis in Composite | . 27 |



# Definitions

Auto-Wake: Sleep Mode (uses AMSR sample rate in SR [0x08] register) Auto-Sleep: Run Mode (uses AWSR sample rate in SR [0x08] register) PMP: Portable Media Player PDA: Personal Digital Assistant DFN: Dual Flat No Lead ESD: Electro Static Discharge ODR: Output Data Rate MEMS: Microelectromechanical Systems



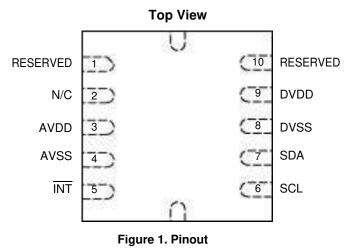
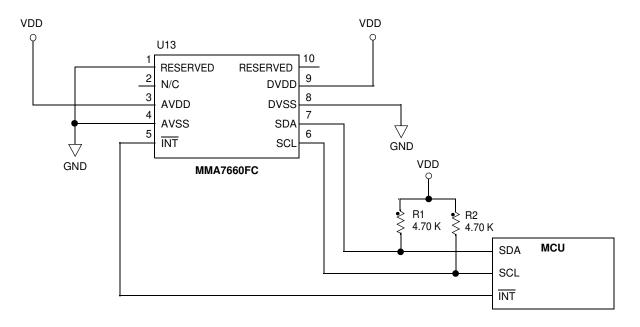


Table 1. Pin Description

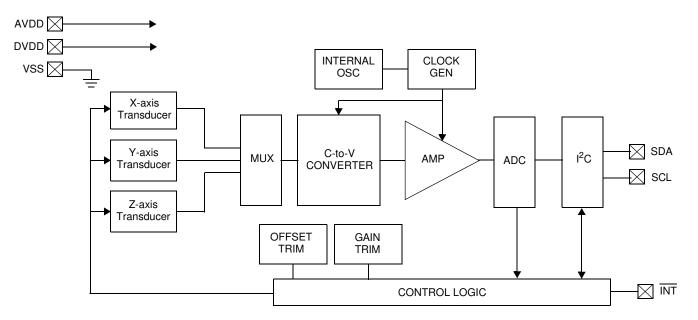
| Pin # | Pin Name | Description   | Pin<br>Status |
|-------|----------|---|---------------|
| 1     | RESERVED | Connect to AVSS   | Input         |
| 2     | N/C      | No Internal Connection, leave<br>unconnected or connect to Ground | Input         |
| 3     | AVDD     | Device Power  | Input         |
| 4     | AVSS     | Device Ground   | Input         |
| 5     | INT      | Interrupt/Data Ready  | Output        |
| 6     | SCL      | I <sup>2</sup> C Serial Clock                                     | Input         |
| 7     | SDA      | I <sup>2</sup> C Serial Data                                      | Open<br>Drain |
| 8     | DVSS     | Digital I/O Ground  | Input         |
| 9     | DVDD     | Digital I/O Power   | Input         |
| 10    | RESERVED | Connect to AVSS   | Input         |



**NOTE:** A 0.1 F ceramic capacitor can be placed connecting pin 3 (AVDD) to pin 4 (AVSS). In addition, another 0.1 F ceramic capacitor can be place connecting pin 9 (DVDD) to pin 8 (DVSS). The capacitors should be placed close to the pins of the MMA7660FC and is recommended for testing and to adequately decouple the accelerometer from noise on the power supply.

## Figure 2. I<sup>2</sup>C Connection to MCU





#### Figure 3. Simplified Accelerometer Functional Block Diagram

#### **Table 2. Maximum Ratings**

(Maximum ratings are the limits to which the device can be exposed without causing permanent damage.)

| Rating                                 | Symbol              | Value        | Unit |
|--|---------------------|--------------|------|
| Maximum Acceleration (all axes, 100 s) | g <sub>max</sub>    | 10,000       | g    |
| Analog Supply Voltage                  | AV <sub>DD</sub>    | -0.3 to +3.6 | V    |
| Digital I/O pins Supply Voltage        | DV <sub>DD_IO</sub> | -0.3 to +3.6 | V    |
| Drop Test                              | D <sub>drop</sub>   | 1.8          | m    |
| Storage Temperature Range              | T <sub>stg</sub>    | -40 to +125  | °C   |

## ELECTRO STATIC DISCHARGE (ESD)

#### WARNING: This device is sensitive to electrostatic discharge.

Although the Freescale accelerometer contains internal 2000 V ESD protection circuitry, extra precaution must be taken by the user to protect the chip from ESD. A charge of over 2000 V can accumulate on the human body or associated test equipment. A charge of this magnitude can alter the performance or cause failure of the chip. When handling the accelerometer, proper ESD precautions should be followed to avoid exposing the device to discharges which may be detrimental to its performance.

| Table 3. ESD And Latch-u | <b>Protection Characteristics</b> |
|--------------------------|-----------------------------------|
|--------------------------|-----------------------------------|

| Rating                                    | Symbol | Value | Unit |
|---|--------|-------|------|
| Human Body Model                          | HBM    | ±2000 | V    |
| Machine Model                             | MM     | ±200  | V    |
| Charge Device Model                       | CDM    | ±500  | V    |
| Latch-up current at T <sub>A</sub> = 85°C |        | ±100  | mA   |



## **Table 4. Operating Characteristics**

Unless otherwise noted: -40°C  $\leq$  T<sub>A</sub>  $\leq$  85°C, 2.4 V  $\leq$  AV<sub>DD</sub>  $\leq$  3.6 V, 1.71 V < DV<sub>DD</sub> < 3.6 V, Acceleration = 0g Typical values are at AV<sub>DD</sub> = 2.8 V, DV<sub>DD</sub> = 2.8 V, T<sub>A</sub> = +25°C

| Characteristics   | Symbol                            | Min                    | Тур      | Max                     | Unit     |
|---|-----------------------------------|------------------------|----------|-------------------------|----------|
| Analog Supply Voltage   |                                   |                        |          |                         |          |
| Standby/Operation Mode  | AV <sub>DD</sub>                  | 2.4                    | 2.8      | 3.6                     | V        |
| Enable Bus Modeon Mode  | AV <sub>DD</sub>                  |                        | 0        |                         | V        |
| Digital I/O Pins Supply Voltage   |                                   |                        |          |                         |          |
| Standby/Operation Mode  | DV <sub>DD_IO</sub>               | 1.71                   | 2.8      | AV <sub>DD</sub>        | V        |
| Enable Bus Modeon Mode  | $DV_{DD\_IO}$                     | 1.71                   | 1.8      | 3.6                     | V        |
| Supply Current Drain  |                                   |                        |          |                         |          |
| Off Mode  | I <sub>DD</sub>                   |                        | 0.4      |                         | μA       |
| Power Down Mode   | I <sub>DD</sub>                   |                        | 2        | 10                      | μA       |
| Standby Mode <sup>(1)</sup>   | I <sub>DD</sub>                   | 0                      | 2        | 10                      | μA       |
| Active Mode, ODR = 1  | I <sub>DD</sub>                   |                        | 47       |                         | μA       |
| Active Mode, ODR = 2  | I <sub>DD</sub>                   |                        | 49       |                         | μA       |
| Active Mode, ODR = 4  | I <sub>DD</sub>                   |                        | 54       |                         | μΑ       |
| Active Mode, ODR = 8  | I <sub>DD</sub>                   |                        | 66<br>89 | +                       | μΑ       |
| Active Mode, ODR = 16<br>Active Mode, ODR = 32  | I <sub>DD</sub>                   | ├                      | 133      | +                       | μΑ       |
| Active Mode, $ODR = 32$<br>Active Mode, $ODR = 64$  | I <sub>DD</sub>                   | <u> </u>               | 221      | +                       | μΑ<br>μΑ |
| Active Mode <sup>(1)</sup> , ODR = 120  | I <sub>DD</sub>                   |                        | 294      |                         | μΑ       |
| Acceleration Range  | I <sub>DD</sub>                   |                        | ±1.5     |                         |          |
| Operating Temperature Range   | T <sub>A</sub>                    | -40                    | ±1.5     | 85                      | g<br>°C  |
| Operating reinperature riange<br>0g Output Signal ( $T_A = 25^{\circ}C$ , $AV_{DD} = 2.8 V$ ) | 'A                                | -40                    | 25       | 00                      | 0        |
| $\frac{0}{0} \text{ Offset } \pm 1.5 \text{g range}^{(1)}$                                    | M                                 | -3                     | 0        | 3                       | oounto   |
| Og Offset Temperature Variation   | V <sub>OFF</sub>                  | -3                     | 0        | 3                       | counts   |
| X   |                                   |                        | -1.3     |                         | mg/°C    |
| Ŷ   |                                   |                        | +1.5     |                         | mg/°C    |
| Z   |                                   |                        | -1.0     |                         | mg/°C    |
| Sensitivity <sup>(1)</sup> (T <sub>A</sub> = 25°C, AV <sub>DD</sub> = 2.8 V)                  |                                   |                        |          |                         | J        |
| ±1.5g range 6-bit   |                                   |                        | 21.33    |                         | count/g  |
| Acceleration Sensitivity at T <sub>AMB</sub>  |                                   | 19.62                  | 21.33    | 23.04                   | count/g  |
| Acceleration Sensitivity Temperature Variation  |                                   |                        | ±0.01    |                         | %/°C     |
| Input High Voltage  | V <sub>IH</sub>                   | 0.7 x D <sub>VDD</sub> |          |                         |          |
| Input Low Voltage   | VIL                               | 100                    |          | 0.35 x D <sub>VDD</sub> |          |
| Output Low Voltage (IOL = 6 mA + SDA, INT)  | V <sub>OL</sub>                   |                        |          | 0.5                     | V        |
| Input Leakage Current   | I <sub>IH</sub> , I <sub>IL</sub> |                        | 0.025    |                         | μA       |
| Internal Clock Frequency <sup>(1)</sup> ( $T_A = 25^{\circ}C$ , $AV_{DD} = 2.8 V$ )           | t <sub>CLK</sub>                  | 135                    | 150      | 165                     | kHz      |
| I <sup>2</sup> C Interface Speed  |                                   |                        |          | 400                     | kHz      |
| Control Timing  |                                   |                        |          |                         |          |
| Turn on time from $AV_{DD} = 0$ V to $AV_{DD} = 2.5$ V <sup>(2)</sup>                         |                                   |                        |          | 1.3                     | ms       |
| Turn off time from Active to Standby Mode   |                                   |                        |          | 1                       | ms       |
| Turn on time Standby to Active Mode   |                                   |                        |          | 12 ms + 1/ODR           | ms       |
| Timing Clock Source Accuracy (T <sub>A</sub> = 25°C, DV <sub>DD</sub> = 1.8 V)                |                                   | -10                    |          | 10                      | %        |
| Timing Clock Source Temperature Variation   |                                   | -15                    |          | 15                      | %        |
| Cross Axis Sensitivity <sup>(3)</sup>   |                                   |                        | ±1       |                         | %        |
| Noise <sup>(4)</sup>  |                                   |                        | ±1       | +                       | count    |

Notes

1. These parameters are tested in production at final test.

2. Assuming VDD power on slope is < 1 ms.

3. A measure of the devices ability to reject an acceleration applied 90° from the true axis of sensitivity.

4. Noise is defined as quantiles given to a sample size. These are the occurrences of noise:  $94\% = \pm 1$  count,  $5\% = \pm 2$  counts, and  $1\% = \pm 3$  counts.



## PRINCIPLE OF OPERATION

The Freescale Accelerometer consists of a MEMS capacitive sensing g-cell and a signal conditioning ASIC contained in a single package. The sensing element is sealed hermetically at the wafer level using a bulk micro machined cap wafer. The g-cell is a mechanical structure formed from semiconductor materials (polysilicon) using masking and etching processes.

The sensor can be modeled as a movable beam that moves between two mechanically fixed beams (Figure 4). Two gaps are formed; one being between the movable beam and the first stationary beam and the second between the movable beam and the second stationary beam.

The ASIC uses switched capacitor techniques to measure the g-cell capacitors and extract the acceleration data from the difference between the two capacitors. The ASIC also signal conditions and filters (switched capacitor) the signal, providing a digital output that is proportional to acceleration.

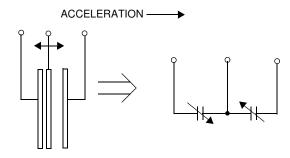


Figure 4. Simplified Transducer Physical Model



## MODES OF OPERATION

The sensor has three power modes: Off Mode, Standby Mode, and Active Mode to offer the customer different power consumption options. The sensor is only capable of running in one of these modes at a time.

The Off Mode offers the lowest power consumption, approximately 0.4  $\mu$ A and can only be reached by powering down the analog supply. See Figure 5. In this mode, there is no analog supply and all I<sup>2</sup>C activity is ignored.

The Standby Mode is ideal for battery operated products. When Standby Mode is active the device outputs are turned off providing a significant reduction in operating current. When the device is in Standby Mode the current will be reduced to approximately 3  $\mu$ A. Standby Mode is entered as soon as both analog and digital power supplies are up. In this mode, the device can read and write to the registers with I<sup>2</sup>C, but no new measurements can be taken. The mode of the device is controlled through the MODE (0x07) control register by accessing the mode bit in the Mode register.

During the Active Mode, continuous measurement on all three axes is enabled. In addition, the user can choose to enable: Shake Detection, Tap Detection, Orientation Detection, and/or Auto-Wake/Sleep Feature and in this mode the digital analysis for any of these functions is done. The user can configure the samples per second to any of the following: 1 sample/second, 2 samples/second, 4 samples/second, 8 samples/second, 16 samples/second, 32 samples/second, 64 samples/second, and 120 samples/second, for the Auto-Sleep state. If the user is configuring the Auto-Wake feature, the selectable ranges are: 1 sample/second, 8 samples/second, 16 samples/seconds and 32 samples/second. Depending on the samples per second selected the power consumption will vary.

| Measurement and<br>Power Mode          | I²C Bus   | DVDD | AVDD | Function  |
|--|---|------|------|---|
| Power Down<br>Mode                     | DVDD is down, so I <sup>2</sup> C bus <i>cannot</i> be used for other devices (MMA7660FC  | Off  | Off  | MMA7660FC is powered down in both supplies. I <sup>2</sup> C activity is unavailable on bus.  |
|  | clamps I <sup>2</sup> C bus to DVVD pin)  | Off  | On   | MMA7660FC is powered down in digital supply but not analog supply. I <sup>2</sup> C activity is unavailable on bus. AVDD power cycling requires 50 msec.  |
| Off Mode                               | MMA7660FC will not respond, but I <sup>2</sup> C<br>bus can be used for other devices<br>(MMA7660FC does not load I <sup>2</sup> C bus) | On   | Off  | MMA7660FC is powered down in analog supply but not digital supply. I <sup>2</sup> C activity is ignored.  |
| Standby Mode                           | MMA7660FC will respond to I <sup>2</sup> C bus  | On   | On   | MMA7660FC is powered up in both supplies, so registers can be accessed normally to set MMA7660FC to Active Mode when desired. MMA7660FC's sensor measurement system is idle.  |
| Active Mode<br>Auto-Sleep<br>Auto-Wake | MMA7660FC will respond to I <sup>2</sup> C bus  | On   | On   | MMA7660FC is able to operate sensor measurement system at<br>user programmable samples per second and run all of the digital<br>analysis functions. Tap detection operates in Active Mode and<br>Auto-Sleep, but not Auto-Wake. |

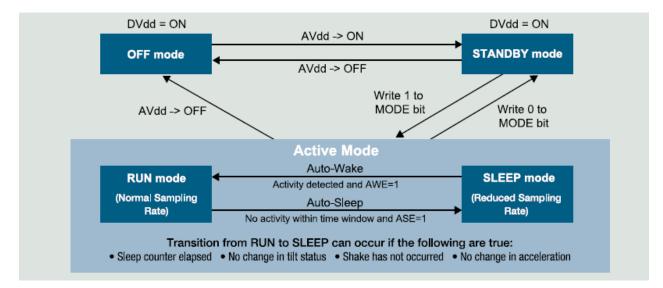


Figure 5. State Machine of Modes



## **CONFIGURABLE SAMPLES PER SECONDS AND INTERRUPT SETTINGS**

The device can be configured into 8 different samples per seconds including: 1 sample/second, 2 samples/second, 4 samples/second, 8 samples/second, 16 samples/second, 32 samples/second, 64 samples/second, and 120 samples/second, The user can specify the samples per second for their particular application, deciding on the trade off between power consumption and number of samples, this can be configured in the SR (0x08) register. Once the user configurable samples per second is chosen, the device will update the data for all 3 axes in the register at a resolution of 6-bits/axis.

The user can choose to enable/disable any of the following interrupts in the INTSU (0x06) register: Front/Back Interrupt, Up/Down/Left/Right Interrupt, Tap Detection Interrupt, GINT (real-time motion tracking), Shake on X-axis, Shake on Y-axis, and Shake on Z-axis. If the GINT is enabled, real-time motion tracking can be configured to trigger an interrupt after every sensor data update: 1s (1 sample/second), 500 ms (2 samples/second), 250 ms (4 samples/second), 125 ms (8 samples/second), 62.5 ms (16 samples/second), 31.25 ms (32 samples/second), 15.625 ms (64 samples/second), or 8.36 ms (120 samples/ second). If any of the shake axis interrupts are enabled; excessive agitation, greater than 1.3 g, will trigger an interrupt. If either the Up/Down/Left/Right Interrupt or the Front/Back Interrupt is enabled, any change in orientation will generate an interrupt. When the Auto-Wake feature is enabled, and the Auto-Sleep counter elapses an interrupt will occur. When the device is in Auto-Sleep state, if a shake interrupt, tap interrupt, Delta G, or orientation detection interrupt occur, the device will go out of sleep state and into wake state.

#### POWER SAVING FEATURES

The MMA7660FC includes a range of user configurable power saving features. The device's samples per second can be set over a wide range from 1 to 120 samples a second; the operating current is directly proportional to samples per second. The analog supply  $A_{VDD}$  can be powered down to put the MMA7660FC into Off Mode, which typically draws 0.4  $\mu$ A. The Auto-Wake/ Sleep feature can toggle the sampling rate from a higher user selected samples per second to a lower user selected samples per second, changing based on if motion is detected or not. The user can choose to use any of the above options to configure the part and make it have the optimal power consumption level for the desired application.

## **TESTING THE LOGIC CHAIN**

MMA7660FC can be put into Test Mode, which disables accelerometer measurements and instead allows the user to write 6-bit values directly to the three axis data registers, thus simulating real time accelerometer measurements. The state machine will respond to these values according to the enabled features and functions, allowing them to be validated.

**NOTE:** MMA7660FC does *not* include an accelerometer self test function, which is typically an electrostatic force applied to each axis to cause it to deflect.

#### FEATURES

The Sensor employs both analog and digital filtering to ensure low noise and accurate output when using the part for Shake, Tap, or Orientation Detection. During Active Mode, the data is filtered and stored for each of the 3 axes at the specified following measurement intervals: 1s (1 sample/second), 500 ms (2 samples/second), 250 ms (4 samples/second), 125 ms (8 samples/second), 62.5 ms (16 samples/second), 31.25 ms (32 samples/second), 15.625 ms (64 samples/second), or 8.36 ms (120 samples/second) or indicated in AMSR [2:0].

The 6-bit measurement data is stored in the XOUT (0x00), YOUT (0x01), and ZOUT (0x02) registers and is used to update the Shake, Alert, Tap, PoLa[2:0] (updates Up, Down, Left, and Right position), and BaFro[1:0] (updates Back and Front position) in the TILT (0x03) register used for orientation detection. The customer can configure the part by enabling a number of user-desired interrupts in the INTSU (0x06) register. Once the interrupts are enabled a change in filtered readings will cause an interrupt to occur depending on the output.

The filters that are being used by this sensor is the analog filtering, digital noise filtering of measurements used for orientation detection and updated in the XOUT (0x00), YOUT (0x01), and ZOUT (0x02) registers. The filtering method used is to oversample each axis by taking 32 readings, and then calculate the average for the output measurement data as a finite impulse response filter.

| Feature             | Will Generate Interrupt         |
|---------------------|---------------------------------|
| Orientation Change  | When FBINT, PLINT = 1           |
| Shake               | When SHINTX, SHINTY, SHINTZ = 1 |
| Tap or Tilt         | When PDINT = 1                  |
| Auto-Wake/Sleep     | When ASINT = 1                  |
| X, Y, Z Data Update | When GINT = 1                   |

#### Table 6. Feature Summary Table

NOTE: Sensor Measurements are NOT taken in Standby Mode or in Test Mode.



#### **Orientation Detection**

#### **Orientation Detection Logic**

MMA7660FC gives the customer the capability to do orientation detection for such applications as Portrait/Landscape in Mobile Phone/PDA/ PMP. The tilt orientation of the device is in 3 dimensions and is identified in its last known static position. This enables a product to set its display orientation appropriately to either portrait/landscape mode, or to turn off the display if the product is placed upside down. The sensor provides six different positions including: Left, Right, Up, Down, Back, and Front, shown in Table 7. In Active Mode the data is processed and updates the orientation positions in the TILT (0x03) register. At each measurement interval, it computes new values for Left, Right, Up, Down, Back, and Front but it does not automatically update these bits in the TILT (0x03) register. These values are updated depending on the debounce filter settings (SR Register 0x08) configured by the customer.

In order to give the customer the ability to configure the debounce filter, specific to there application, they can change the following bits in the SR (0x08) register, FILT [2:0]. Please see below for a more detailed explanation of how the FILT [2:0] works in conjunction with updating the TILT (0x03) register:

- If FILT [2:0] = 000, then the new values for Left, Right, Up, Down, Back, and Front are updated in the TILT (0x03) register (PoLa [2:0] and BaFro [1:0]) after every reading without any further analysis.
- If FILT [2:0] = 001 111, then the sensor requires the computed values for Left, Right, Up, Down, Back, and Front to be the same from 1-7 consecutive readings (depending on the value in FILT [2:0], before updating the values stored in TILT (0x03) register (PoLa [2:0] and BaFro [1:0]). The debounce counter is reset after a mismatched reading or the TILT (0x03) register is updated (if the orientation condition is met).

| Orientation | Xg                                    |    | Yg                                    |    | Zg         |
|-------------|---------------------------------------|----|---------------------------------------|----|------------|
| Shake       | X  > +1.3g                            | or | Y  > +1.3g                            | or | Z  > +1.3g |
| Up          | Z  < 0.8g and $ X  >  Y $ and $X < 0$ |    |                                       |    |            |
| Down        | Z  < 0.8g and $ X  >  Y $ and $X > 0$ |    |                                       |    |            |
| Right       |                                       |    | Z  < 0.8g and $ Y  >  X $ and $Y < 0$ |    |            |
| Left        |                                       |    | Z  < 0.8g and $ Y  >  X $ and $Y > 0$ |    |            |
| Back        |                                       |    |                                       |    | Z < -0.25g |
| Front       |                                       |    |                                       |    | Z > 0.25g  |

#### Table 7. Orientation Detection Logic of when Interrupt will Occur

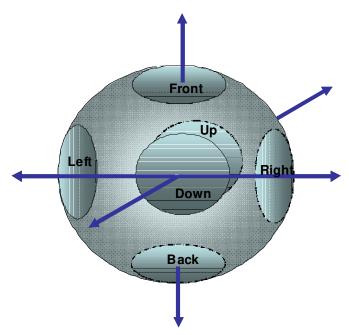


Figure 6. Orientation Detection Logic in 3-Dimensional Space



#### Tap Detection

The MMA7660FC also includes a Tap Detection feature that can be used for a number of different customer applications such as button replacement. For example, a single tap can stop a song from playing and a double tap can play a song. This function detects a fast transition that exceeds a user-defined threshold (PDET (0x09) register) for a set duration (PD (0x0A) register).

#### **Tap Detection Setup**

In order to enable Tap detection in the device the user must enable the Tap Interrupt in the INTSU (0x06) register and AMSR [2:0] = 000 in the SR (0x08) register. In this mode, TILT (0x03) register, XOUT (0x00), YOUT (0x01), and ZOUT (0x02) registers will update at the 120 samples/second.

The user can configure Tap Detection to be detected on X and/or Y and/or Z axes. The customer can configure this by changing the XDA, YDA, and/or ZDA bit in the PDET (0x09) register. Detection for enabled axes is decided on an OR basis: If the PDINT bit is set in the INTSU (0x06) register, the device reports the first axis for which it detects a tap by the Tap bit in the TILT (0x03) register. When the Tap bit in the TILT (0x03) register is set, tap detection ceases, but the device will continue to process orientation detection data. Tap detection will resume when the TILT (0x03) register is read.

**NOTE:** Delta G is available with any AMSR setting, when XDA = YDA = ZDA = 1 (PDET = 1). When the sampling rate is less than 120 samples/second, the device can not detect tapping, but can detect small tilt angles (30 ° angle change) which can not be detected by orientation detection.

#### Shake Detection

The shake feature can be used as a button replacement to perform functions such as scrolling through images or web pages on a Mobile Phone/PMP/PDA. The customer can enable the shake interrupt on any of the 3 axes, by enabling the SHINTX, SHINTY, and/or SHINTZ in the INTSU (0x06) register.

MMA7660FC detects shake by examining the current 6-bit measurement for each axis in XOUT, YOUT, and ZOUT. The axes that are tested for shake detection are the ones enabled by SHINTX, SHINTY, and/or SHINTZ. If a selected axis measures greater that 1.3 or less than -1.3 g, then a shake is detected for that axis and an interrupt occurs. All three axes are checked independently, but a common Shake bit in the TILT register is set when shake is detected in any one of the selected axes. Therefore when all three (SHINTX, SHINTY, and/or SHINTZ) are selected the sensor will not know what axis the shake occurred. When the TILT register is read the Shake bit is cleared during the acknowledge bit of the read access to that register and shake detection monitoring starts again.

#### Auto-Wake/Sleep

The MMA7660FC has the Auto-Wake/Sleep feature that can be enabled for power saving. In the Auto-Wake function, the device is put into a user specified low samples per second (1 sample/second, 8 samples/second, 16 samples/second, or 32 samples/second) in order to minimize power consumption. When the Auto-Wake is enabled and activity is detected such as a change in orientation, pulse event, Delta G acceleration or a shake event, then the device wakes up. Auto-Wake will automatically enable Auto-Sleep when the device is in wake mode and can therefore be configured to cause an interrupt on wake-up, by configuring the part to either wake-up with a change in orientation, shake, or if using the part at 120 samples/second tap detection. When the device is in Auto-Wake mode, the MODE (0x07) register, bit AWE is high. When the device has detected a change in orientation, a tap shake, or Delta G (change in acceleration), the device will enter Auto-Sleep mode. In the Auto-Sleep function, the device is put into any of the following user specified samples per seconds (1 sample/second, 2 samples/second, 4 samples/second, 8 samples/second, 16 samples/second, 32 samples/second, 64 samples/second, and 120 samples/second). In the Auto-Sleep mode, if no change in the orientation, shake or tap has occurred and the sleep counter has elapsed, the device will go into the Auto-Wake mode. When the device is in the Auto-Sleep mode, the MODE (0x07) register, bit ASE is high. The device can be programmed to continually cycle between Auto-Wake/Sleep.

**NOTE:** The device can either be powered on in Wake/Sleep state depending on ASE/AWE settings. If the AWE bit is set, the device is powered on in, in sleep state. If the ASW bit is set, the device is powered on in, in wake state.

|   | Trigger Wake-up              | Reset Sleep Counter | Trigger Sleep Mode |
|---|------------------------------|---------------------|--------------------|
| Orientation Detection Change                    | Yes                          | Yes                 | No                 |
| Shake   | Yes                          | Yes                 | No                 |
| Delta G<br>(set with PD (0x0A) and PDET (0x09)) | Yes<br>(XDA = YDA = ZDA = 0) | Yes                 | No                 |
| Pulse Detect (120 samples/second)               | Yes                          | Yes                 | No                 |
| Sleep Counter Elapsed                           | No                           | No                  | Yes                |

#### Table 8. Auto-Wake/Sleep Truth Table



## **REGISTER DEFINITIONS**

#### Table 9. User Register Summary

| Address   | Name    | Definition  | Bit 7   | Bit 6   | Bit 5   | Bit 4   | Bit 3   | Bit 2   | Bit 1    | Bit 0    |
|-----------|---------|---|---------|---------|---------|---------|---------|---------|----------|----------|
| \$00      | XOUT    | 6-bit output value X  | -       | Alert   | XOUT[5] | XOUT[4] | XOUT[3] | XOUT[2] | XOUT[1]  | XOUT[0]  |
| \$01      | YOUT    | 6-bit output value Y  | -       | Alert   | YOUT[5] | YOUT[4] | YOUT[3] | YOUT[2] | YOUT[1]  | YOUT[0]  |
| \$02      | ZOUT    | 6-bit output value Z  | -       | Alert   | ZOUT[5] | ZOUT[4] | ZOUT[3] | ZOUT[2] | ZOUT[1]  | ZOUT[0]  |
| \$03      | TILT    | Tilt Status   | Shake   | Alert   | Тар     | PoLa[2] | PoLa[1] | PoLa[0] | BaFro[1] | BaFro[0] |
| \$04      | SRST    | Sampling Rate Status  | 0       | 0       | 0       | 0       | 0       | 0       | AWSRS    | AMSRS    |
| \$05      | SPCNT   | Sleep Count   | SC[7]   | SC[6]   | SC[5]   | SC[4]   | SC[3]   | SC[2]   | SC[1]    | SC[0]    |
| \$06      | INTSU   | Interrupt Setup   | SHINTX  | SHINTY  | SHINTZ  | GINT    | ASINT   | PDINT   | PLINT    | FBINT    |
| \$07      | MODE    | Mode  | IAH     | IPP     | SCPS    | ASE     | AWE     | TON     | -        | MODE     |
| \$08      | SR      | Auto-Wake/Sleep and<br>Portrait/Landscape samples<br>per seconds and Debounce<br>Filter | FILT[2] | FILT[1] | FILT[0] | AWSR[1] | AWSR[0] | AMSR[2] | AMSR[1]  | AMSR[0]  |
| \$09      | PDET    | Tap Detection   | ZDA     | YDA     | XDA     | PDTH[4] | PDTH[3] | PDTH[2] | PDTH[1]  | PDTH[0]  |
| \$0A      | PD      | Tap Debounce Count  | PD[7]   | PD[6]   | PD[5]   | PD[4]   | PD[3]   | PD[2]   | PD[1]    | PD[0]    |
| \$0B-\$1F | Factory | Reserved  | -       | -       | -       | -       | -       | -       | -        | -        |

NOTE: To write to the registers the MODE bit in the MODE (0x07) register must be set to 0, placing the device in Standby Mode.

# \$00: 6-bits output value X (Read Only when not in Test Mode) *XOUT — X Output*

| D7 | D6    | D5      | D4      | D3      | D2      | D1      | D0      |
|----|-------|---------|---------|---------|---------|---------|---------|
| -  | Alert | XOUT[5] | XOUT[4] | XOUT[3] | XOUT[2] | XOUT[1] | XOUT[0] |
| 0  | 0     | 0       | 0       | 0       | 0       | 0       | 0       |

Signed byte 6-bit 2's complement data with allowable range of +31 to -32.

XOUT[5] is 0 if the g direction is positive, 1 if the g direction is negative.

If the Alert bit is set, the register was read at the same time as the device was attempting to update the contents. The register must be read again.

#### \$01: 6-bits output value Y (Read Only when not in Test Mode) YOUT — Y Output

| D7 | D6    | D5      | D4      | D3      | D2      | D1      | D0      |
|----|-------|---------|---------|---------|---------|---------|---------|
| -  | Alert | YOUT[5] | YOUT[4] | YOUT[3] | YOUT[2] | YOUT[1] | YOUT[0] |
| 0  | 0     | 0       | 0       | 0       | 0       | 0       | 0       |

Signed byte 6-bit 2's complement data with allowable range of +31 to -32.

YOUT[5] is 0 if the g direction is positive, 1 if the g direction is negative.

If the Alert bit is set, the register was read at the same time as the device was attempting to update the contents. The register must be read again.

### \$02: 6-bits output value Z (Read Only when not in Test Mode) ZOUT — Z Output

| D7 | D6    | D5      | D4       | D3      | D2      | D1      | D0      |
|----|-------|---------|----------|---------|---------|---------|---------|
| -  | Alert | ZOUT[5] | ZXOUT[4] | ZOUT[3] | ZOUT[2] | ZOUT[1] | ZOUT[0] |
| 0  | 0     | 0       | 0        | 0       | 0       | 0       | 0       |

Signed byte 6-bit 2's complement data with allowable range of +31 to -32.

ZOUT[5] is 0 if the g direction is positive, 1 if the g direction is negative.

If the Alert bit is set, the register was read at the same time as the device was attempting to update the contents. The register must be read again.



## \$03: Tilt Status (Read only)

#### TILT

| D7    | D6    | D5  | D4      | D3      | D2      | D1       | D0       |
|-------|-------|-----|---------|---------|---------|----------|----------|
| Shake | Alert | Тар | PoLa[2] | PoLa[1] | PoLa[0] | BaFro[1] | BaFro[0] |
| 0     | 0     | 0   | 0       | 0       | 0       | 0        | 0        |

## BaFro[1:0]

00:Unknown condition of front or back 01: Front: Equipment is lying on its front 10: Back: Equipment is lying on its back

## PoLa[2:0]

000: Unknown condition of up or down or left or right 001: Left: Equipment is in landscape mode to the left 010: Right: Equipment is in landscape mode to the right 101: Down: Equipment standing vertically in inverted orientation

110: Up: Equipment standing vertically in normal orientation

## Тар

1: Equipment has detected a tap

0: Equipment has not detected a tap

## Alert

0: Register data is valid

1: The register was read at the same time as MMA7660FC was attempting to update the contents. Re-read the register

## Shake

0: Equipment is not experiencing shake in one or more of the axes enabled by SHINTX, SHINTY, and SHINTZ

1: Equipment is experiencing shake in one or more of the axes enabled by SHINTX, SHINTY, and SHINTZ

**Note:** When entering active mode from standby mode, if the device is flat  $(\pm 1g \text{ on } Z\text{-}axis)$  the value for BaFro will be back (-1g) or front (+1g) but PoLa will be in unknown condition. if the device is being held in an Up/Down/Right/Left position, the PoLa value will be updated with current orientation, but BaFro will be in unknown condition.

## \$04: Sample Rate Status Register (Read only)

SRST

| D7 | D6 | D5 | D4 | D3 | D2 | D1    | D0    |
|----|----|----|----|----|----|-------|-------|
| 0  | 0  | 0  | 0  | 0  | 0  | AWSRS | AMSRS |
| 0  | 0  | 0  | 0  | 0  | 0  | 0     | 0     |

#### AMSRS

AWSRS

0: Samples per second specified in AMSR[2:0] is not active

1: Samples per second specified in AMSR[2:0] is active

0: Samples per second specified in AWSR[1:0] is not active 1: Samples per second specified in AWSR[1:0] is active

## \$05: Sleep Count Register (Read/Write) SPCNT

| D7    | D6    | D5    | D4    | D3    | D2    | D1    | D0    |
|-------|-------|-------|-------|-------|-------|-------|-------|
| SC[7] | SC[6] | SC[5] | SC[4] | SC[3] | SC[2] | SC[1] | SC[0] |
| 0     | 0     | 0     | 0     | 0     | 0     | 0     | 0     |

Writing to the SPCNT (0x05) register resets the internal sleep counter.

## SC[7:0]

Sets the 8-bit maximum count value for the 8-bit internal sleep counter in Auto-Sleep. When the 8-bit internal sleep counter reaches the value set by SC[7:0], MMA7660FC will exit Auto-Sleep and switch to the samples per second specified in AWSR[1:0] of the SR (0x08) register.



## \$06: Interrupt Setup Register

INTSU

| ſ | D7     | D6     | D5     | D4   | D3    | D2    | D1    | D0    |
|---|--------|--------|--------|------|-------|-------|-------|-------|
| Ī | SHINTX | SHINTY | SHINTZ | GINT | ASINT | PDINT | PLINT | FBINT |
| ĺ | 0      | 0      | 0      | 0    | 0     | 0     | 0     | 0     |

## FBINT

0: Front/Back position change does not cause an interrupt 1: Front/Back position change causes an interrupt

## PLINT

0: Up/Down/Right/Left position change does not cause an interrupt

1: Up/Down/Right/Left position change causes an interrupt PDINT

0: Successful tap detection does not cause an interrupt

1: Successful tap detection causes an interrupt

## ASINT

0: Exiting Auto-Sleep does not cause an interrupt

1: Exiting Auto-Sleep causes an interrupt

## GINT

0: There is not an automatic interrupt after every measurement

1: There is an automatic interrupt after every measurement, when g-cell readings are updated in XOUT, YOUT, ZOUT registers, regardless of whether the readings have changed or not. This interrupt does not affect the Auto-Sleep or Auto-Wake functions.

## SHINTX

0: Shake on the X-axis does not cause an interrupt or set the Shake bit in the TILT register

1: Shake detected on the X-axis causes an interrupt, and sets the Shake bit in the TILT register

## SHINTY

0: Shake on the Y-axis does not cause an interrupt or set the Shake bit in the TILT register

1: Shake detected on the Y-axis causes an interrupt, and sets the Shake bit in the TILT register

## SHINTZ

0: Shake on the Z-axis does not cause an interrupt or set the Shake bit in the TILT register

1: Shake detected on the Z-axis causes an interrupt, and sets the Shake bit in the TILT register.

The active interrupt condition (IRQ = 0 if IAH = 0, IRQ = 1 if IAH = 1) is released during the acknowledge bit of the slave address transmission of the first subsequent I<sup>2</sup>C to MMA7660FC after the interrupt was asserted.



## \$07: Mode Register (Read/Write)

MODE

| D7  | D6  | D5   | D4  | D3  | D2  | D1 | D0   |
|-----|-----|------|-----|-----|-----|----|------|
| IAH | IPP | SCPS | ASE | AWE | TON | -  | MODE |
| 0   | 0   | 0    | 0   | 0   | 0   | 0  | 0    |

**NOTE:** Writing to the Mode register resets sleep timing, and clears the XOUT, YOUT, ZOUT, TILT registers.Reading to the Mode register resets sleep timing.

NOTE: The device must be placed in Standby Mode to change the value of the registers.

| Table | 10. | Modes |
|-------|-----|-------|
| IUNIC |     | mouco |

| Mode of Operation | D0 - MODE | D2 - TON |
|-------------------|-----------|----------|
| Standby Mode      | 0         | 0        |
| Test Mode         | 0         | 1        |
| Active Mode       | 1         | 0        |

**NOTE:** The device can only enter into Test Mode, when the previous mode was Standby Mode. If the device was in Active mode, set MMA766FC to Standby Mode (MODE = TON = 0), then enter Test Mode (MODE = 0, TON = 1).

## MODE

0: Standby mode or Test Mode depending on state of TON 1: Active mode

Existing state of TON bit must be 0, to write MODE = 1. Test Mode must not be enabled.

MMA7660FC always enters Active Mode using the samples per second specified in AMSR[2:0] of the SR (0x08) register. When MMA7660FC enters Active Mode with

[ASE:AWE] = 11, MMA7660FC operates Auto-Sleep functionality first.

## TON

0: Standby Mode or Active Mode depending on state of MODE

1: Test Mode

Existing state of MODE bit must be 0, to write TON = 1. Device must be in Standby Mode.

In Test Mode (TON = 1), the data in the XOUT, YOUT and ZOUT registers is *not* updated by measurement, but is instead updated by the user through the  $I^2C$  interface for test purposes. Changes to the XOUT, YOUT and ZOUT register data is processed by MMA7660FC to change orientation status and generate interrupts just like Active Mode. Debounce filtering and shake detection are disabled in Test Mode.

## AWE

0: Auto-Wake is disabled

1: Auto-Wake is enabled.

When Auto-Wake functionality is operating, the AWSRS bit is the SRST register is set and the device uses the samples per second specified in AWSR[1:0] of the SR (0x08) register. When MMA7660FC automatically exits Auto-Wake by a selected interrupt, the device will then switch to the samples per second specified in AMSR[2:0] of the SR (0x08) register. If ASE = 1, then Auto-Sleep functionality is now enabled (Table 11). ASE

0: Auto-Sleep is disabled

1: Auto-Sleep is enabled

When Auto-Sleep functionality is operating, the AMSRS bit is the SRST register is set and the device uses the samples per second specified in AMSR[2:0] of the SR (0x08) register. When MMA7660FC automatically exits Auto-Sleep because the Sleep Counter times out, the device will then switch to the samples per second specified in AWSR[1:0] of the SR register. If AWE = 1, then Auto-Wake functionality is now enabled (Table 11).

## SCPS

0: The prescaler is divide-by-1. The 8-bit internal Sleep Counter input clock is the samples per second set by AMSR[2:0], so the clock range is 120 Hz to 1 Hz depending on AMSR[2:0] setting. Sleep Counter timeout range is 256 times the prescaled clock (see Table 12).

1: Prescaler is divide-by-16. The 8-bit Sleep Counter input clock is the samples per second set by AMSR[2:0] divided by 16, so the clock range is 4 Hz to 0.0625 Hz depending on AMSR[2:0] setting. Sleep Counter timeout range is 256 times the prescaled clock (see Table 12).

## IPP

0: Interrupt output INT is open-drain.

1: Interrupt output INT is push-pull

**NOTE:** Do NOT connect pull-up resistor from INT to higher voltage than DVDD.

## IAH

0: Interrupt output INT is active low 1: Interrupt output INT is active high

The active interrupt condition ( $\overline{IRQ} = 0$  if IAH = 0,  $\overline{IRQ} = 1$  if IAH = 1) is released during the acknowledge bit of the slave address transmission of the first subsequent I<sup>2</sup>C to the device after the interrupt was asserted.



## Table 11. ASE/AWE Conditions

| Condition        | Auto-Wake (Sleep Mode) | Auto-Sleep (Run Mode) |
|------------------|------------------------|-----------------------|
| AWE = 0, ASE = 0 |                        | Х                     |
| AWE = 1, ASE = 0 | Х                      |                       |
| AWE = 0, ASE = 1 | Х                      | Х                     |
| AWE = 1, ASE = 1 | Х                      | Х                     |

**NOTE:** If interrupts are enabled, interrupts will behave normally in all conditions stated in Table 11.

#### Table 12. Sleep Counter Timeout Ranges

|         | SCP                             | S = 0                           | SCPS = 1                        |                                 |  |  |
|---------|---------------------------------|---------------------------------|---------------------------------|---------------------------------|--|--|
| AMSR    | Minimum Range (2 <sup>0</sup> ) | Maximum Range (2 <sup>8</sup> ) | Minimum Range (2 <sup>0</sup> ) | Maximum Range (2 <sup>8</sup> ) |  |  |
| 1 SPS   | 1 s                             | 256 s                           | 16 s                            | 4096 s                          |  |  |
| 2 SPS   | 0.5 s                           | 128 s                           | 8 s                             | 2048 s                          |  |  |
| 4 SPS   | 0.25 s                          | 34 s                            | 4 s                             | 1024 s                          |  |  |
| 8 SPS   | 0.125 s                         | 32 s                            | 2 s                             | 512 s                           |  |  |
| 16 SPS  | 0.625 s                         | 16 s                            | 1 s                             | 256 s                           |  |  |
| 32 SPS  | 0.03125 s                       | 8 s                             | 0.5 s                           | 128 s                           |  |  |
| 64 SPS  | 0.0156 s                        | 4 s                             | 0.25 s                          | 64 s                            |  |  |
| 120 SPS | 0.00836 s                       | 2.14 s                          | 0.133 s                         | 34.24 s                         |  |  |

# \$08: Auto-Wake and Active Mode Portrait/Landscape Samples per Seconds Register (Read/Write) *SR — Sample Rate Register*

| D7      | D6      | D5      | D4      | D3      | D2      | D1      | D0      |
|---------|---------|---------|---------|---------|---------|---------|---------|
| FILT[2] | FILT[1] | FILT[0] | AWSR[1] | AWSR[0] | AMSR[2] | AMSR[1] | AMSR[0] |
| 0       | 0       | 0       | 0       | 0       | 0       | 0       | 0       |



| AMSR[2:0] | NAME | DESCRIPTION   |
|-----------|------|---|
| 000       | AMPD | <ul> <li>Tap Detection Mode and 120 Samples/Second Active and Auto-Sleep Mode</li> <li>Tap Detection Sampling Rate: The device takes readings continually at a rate of nominally 3846 g-cell measurements a second. It then filters these high speed measurements by maintaining continuous rolling averages of the current and last g-cell measurements. The averages are updated every 260 µs to track fast moving accelerations. Tap detection: itself compares the two filtered axis responses (fast and slow) described above for each axis. The absolute (unsigned) difference between the fast and slow axis responses is compared against the tap detection delta threshold value PDTH[4:0] in the PDET (0x09) register.</li> <li>For portrait/landscape detection: The device takes and averages 32 g-cell measurements every 8.36 ms in Active Mode and Auto-Sleep. The update rate is 120 samples per second. These measurements update the XOUT (0x00), YOUT (0x01), and ZOUT (0x02) registers also.</li> </ul> |
| 001       | AM64 | 64 Samples/Second Active and Auto-Sleep Mode<br><b>For portrait/landscape detection</b> : The device takes and averages 32 g-cell measurements every<br>15.625 ms in Active Mode and Auto-Sleep. The update rate is 64 samples per second. These measurements update<br>the XOUT (0x00), YOUT (0x01), and ZOUT (0x02) registers also.   |
| 010       | AM32 | 32 Samples/Second Active and Auto-Sleep Mode<br><b>For portrait/landscape detection:</b> The device takes and averages 32 g-cell measurements every 31.25 ms in Active<br>Mode and Auto-Sleep. The update rate is 32 samples per second. These measurements update XOUT (0x00), YOUT<br>(0x01), and ZOUT (0x02) registers also.   |
| 011       | AM16 | 16 Samples/Second Active and Auto-Sleep Mode<br><b>For portrait/landscape detection:</b> The device takes and averages 32 g-cell measurements every 62.5 ms in Active<br>Mode and Auto-Sleep. The update rate is 16 samples per second. These measurements update the XOUT (0x00),<br>YOUT (0x01), and ZOUT (0x02) registers also.  |
| 100       | AM8  | 8 Samples/Second Active and Auto-Sleep Mode<br><b>For portrait/landscape detection:</b> The device takes and averages 32 g-cell measurements every 125 ms in Active<br>Mode and Auto-Sleep. The update rate is 8 samples per second. These measurements update the XOUT (0x00),<br>YOUT (0x01), and ZOUT (0x02) registers also.   |
| 101       | AM4  | 4 Samples/Second Active and Auto-Sleep Mode<br><b>For portrait/landscape detection:</b> The device takes and averages 32 g-cell measurements every 250 ms in Active<br>Mode and Auto-Sleep. The update rate is 4 samples per second. These measurements update the XOUT (0x00),<br>YOUT (0x01), and ZOUT (0x02) registers also.   |
| 110       | AM2  | 2 Samples/Second Active and Auto-Sleep Mode<br><b>For portrait/landscape detection:</b> The device takes and averages 32 g-cell measurements every 500 ms in Active<br>Mode and Auto-Sleep. The update rate is 2 samples per second. These measurements update the XOUT (0x00),<br>YOUT (0x01), and ZOUT (0x02) registers also.   |
| 111       | AM1  | 1 Sample/Second Active and Auto-Sleep Mode<br><b>For portrait/landscape detection:</b> The device takes and averages 32 g-cell measurements every 1000 ms in Active<br>Mode and Auto-Sleep. The update rate is 1 sample per second. These measurements update the XOUT (0x00), YOUT<br>(0x01), and ZOUT (0x02) registers also.  |



| AWSR[1:0] | NAME | DESCRIPTION  |
|-----------|------|--|
| 00        | AW32 | 32 Samples/Second Auto-Wake Mode   |
|           |      | For portrait/landscape detection: The device takes and averages 32 g-cell measurements every 31.25 ms in |
|           |      | Auto-Wake. The update rate is 32 samples per second. These measurements update the XOUT (0x00), YOUT     |
|           |      | (0x01), and ZOUT (0x02) registers also.  |
| 01        | AW16 | 16 Samples/Second Auto-Wake Mode   |
|           |      | For portrait/landscape detection: The device takes and averages 32 g-cell measurements every 62.5 ms in  |
|           |      | Auto-Wake. The update rate is 16 samples per second. These measurements update the XOUT (0x00), YOUT     |
|           |      | (0x01), and ZOUT (0x02) registers also.  |
| 10        | AW8  | 8 Samples/Second Auto-Wake Mode  |
|           |      | For portrait/landscape detection: The device takes and averages 32 g-cell measurements every 125 ms in   |
|           |      | Auto-Wake. The update rate is 8 samples per second. These measurements update the XOUT (0x00), YOUT      |
|           |      | (0x01), and ZOUT (0x02) registers also.  |
| 11        | AW1  | 1 Sample/Second Auto-Wake Mode   |
|           |      | For portrait/landscape detection: The device takes and averages 32 g-cell measurements every 1000 ms in  |
|           |      | Auto-Wake. The update rate is 1 sample per second. These measurements update the XOUT (0x00), YOUT       |
|           |      | (0x01), and ZOUT (0x02) registers also.  |

| FILT[2:0] | DESCRIPTION  |
|-----------|--|
| 000       | Tilt debounce filtering is disabled. The device updates portrait/landscape every reading at the rate set by AMSR[2:0] or |
|           | AWSR[1:0]  |
| 001       | 2 measurement samples at the rate set by AMSR[2:0] or AWSR[1:0] have to match before the device updates portrait/        |
|           | landscape data in TILT (0x03) register.  |
| 010       | 3 measurement samples at the rate set by AMSR[2:0] or AWSR[1:0] have to match before the device updates portrait/        |
|           | landscape data in TILT (0x03) register.  |
| 011       | 4 measurement samples at the rate set by AMSR[2:0] or AWSR[1:0] have to match before the device updates portrait/        |
|           | landscape data in TILT (0x03) register.  |
| 100       | 5 measurement samples at the rate set by AMSR[2:0] or AWSR[1:0] have to match before the device updates portrait/        |
|           | landscape data in TILT (0x03) register.  |
| 101       | 6 measurement samples at the rate set by AMSR[2:0] or AWSR[1:0] have to match before the device updates portrait/        |
|           | landscape data in TILT (0x03) register.  |
| 110       | 7 measurement samples at the rate set by AMSR[2:0] or AWSR[1:0] have to match before the device updates portrait/        |
|           | landscape data in TILT (0x03) register.  |
| 111       | 8 measurement samples at the rate set by AMSR[2:0] or AWSR[1:0] have to match before the device updates portrait/        |
|           | landscape data in TILT (0x03) register.  |

## \$09: Tap/Pulse Detection Register (Read/Write)

PDET

| D7  | D6          | D5 | D4      | D3      | D2      | D1      | D0      |
|-----|-------------|----|---------|---------|---------|---------|---------|
| ZDA | ZDA YDA XDA |    | PDTH[4] | PDTH[3] | PDTH[2] | PDTH[1] | PDTH[0] |
| 0   | 0           | 0  | 0       | 0       | 0       | 0       | 0       |

**NOTE:** If XDA = YDA = ZDA = 0, samples per second is 120 samples/second, and Auto-Wake/Sleep feature is enabled, the tap interrupt will reset the sleep counter.

| PDTH[4:0] | DESCRIPTION                           |
|-----------|---------------------------------------|
| 00000     | Ten detection threshold is 11 count   |
| 00001     | Tap detection threshold is ±1 count   |
| 00010     | Tap detection threshold is ±2 counts  |
| 00011     | Tap detection threshold is ±3 counts  |
|           | and so on up to                       |
| 11101     | Tap detection threshold is ±29 counts |
| 11110     | Tap detection threshold is ±30 counts |
| 11111     | Tap detection threshold is ±31 counts |

#### XDA

1: X-axis is disabled for tap detection 0: X-axis is enabled for tap detection

### ZDA

1: Z-axis is disabled for tap detection

0: Z-axis is enabled for tap detection

## YDA

1: Y-axis is disabled for tap detection

0: Y-axis is enabled for tap detection

## \$0A: PD: Tap/Pulse Debounce Count Register (Read/Write)

| D7    | D6                | D5 | D4    | D3    | D2    | D1    | D0    |
|-------|-------------------|----|-------|-------|-------|-------|-------|
| PD[7] | PD[7] PD[6] PD[5] |    | PD[4] | PD[3] | PD[2] | PD[1] | PD[0] |
| 0     | 0 0               |    | 0     | 0     | 0     | 0     | 0     |

| PD[4:0]  | DESCRIPTION  |
|----------|--|
| 00000000 | The tap detection debounce filtering requires 2 adjacent tap detection tests to be the same to trigger a tap event and set the   |
| 00000001 | <ul> <li>Tap bit in the TILT (0x03) register, and optionally set an interrupt if PDINT is set in the INTSU (0x06) register. Tap detection<br/>response time is nominally 0.52 ms.</li> </ul>   |
| 00000010 | Tap detection debounce filtering requires 3 adjacent tap detection tests to be the same to trigger a tap event and set the Tap bit in the TILT (0x03) register, and optionally set an interrupt if PDINT is set in the INTSU (0x06) register. Tap detection response time is nominally 0.78 ms.    |
| 00000011 | Tap detection debounce filtering requires 4 adjacent tap detection tests to be the same to trigger a tap event and set the Tap bit in the TILT (0x03) register, and optionally set an interrupt if PDINT is set in the INTSU (0x06) register. Tap detection response time is nominally 1.04 ms.    |
|          | and so on up to  |
| 11111101 | Tap detection debounce filtering requires 254 adjacent tap detection tests to be the same to trigger a tap event and set the Tap bit in the TILT (0x03) register, and optionally set an interrupt if PDINT is set in the INTSU (0x06) register. Tap detection response time is nominally 66.04 ms. |
| 11111110 | Tap detection debounce filtering requires 255 adjacent tap detection tests to be the same to trigger a tap event and set the Tap bit in the TILT (0x03) register, and optionally set an interrupt if PDINT is set in the INTSU (0x06) register. Tap detection response time is nominally 66.3 ms.  |
| 11111111 | Tap detection debounce filtering requires 256 adjacent tap detection tests to be the same to trigger a tap event and set the Tap bit in the TILT (0x03) register, and optionally set an interrupt if PDINT is set in the INTSU (0x06) register. Tap detection response time is nominally 66.56 ms. |



## SERIAL INTERFACE

#### Serial-Addressing

MMA7660FC operates as a slave that sends and receives data through an I<sup>2</sup>C 2-wire interface. The interface uses a Serial Data Line (SDA) and a Serial Clock Line (SCL) to achieve bi-directional communication between master(s) and slave(s). A master (typically a microcontroller) initiates all data transfers to and from the device, and generates the SCL clock that synchronizes the data transfer.

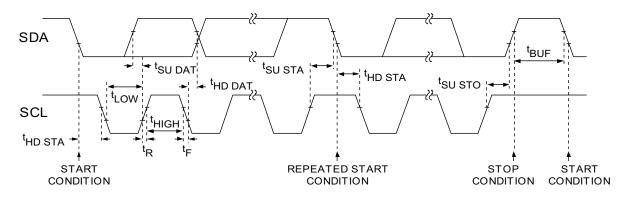
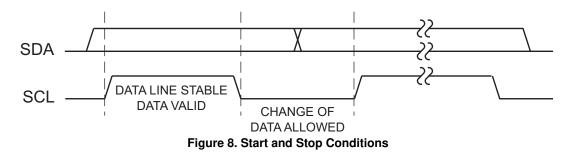


Figure 7. 2-Wire Serial Interface Timing Details

The device's SDA line operates as both an input and an open-drain output. A pull-up resistor, typically 4.7 k $\Omega$ , is required on SDA. The device's SCL line operates only as an input. A pull-up resistor, typically 4.7 k $\Omega$ , is required on SCL if there are multiple masters on the 2-wire interface, or if the master in a single-master system has an open-drain SCL output.

Each transmission consists of a START condition (Figure 7) sent by a master, followed by MMA7660FC's 7-bit slave address plus R/W bit, a register address byte, one or more data bytes, and finally a STOP condition.

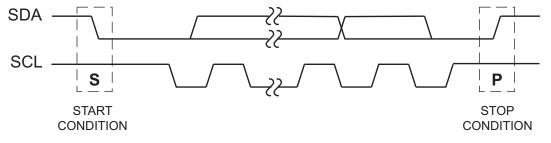


## Start and Stop Conditions

Both SCL and SDA remain high when the interface is not busy. A master signals the beginning of a transmission with a START (S) condition by transitioning SDA from high to low while SCL is high. When the master has finished communicating with the slave, it issues a STOP (P) condition by transitioning SDA from low to high while SCL is high. The bus is then free for another transmission.

#### **Bit Transfer**

One data bit is transferred during each clock tap. See Figure 9. The data on SDA must remain stable while SCL is high.







#### Acknowledge

The acknowledge bit is a clocked 9th bit, shown in Figure 10, which the recipient uses to handshake a receipt of each byte of data. Thus each byte transferred effectively requires 9-bits. The master generates the 9<sup>th</sup> clock tap, and the recipient pulls down SDA during the acknowledge clock tap, such that the SDA line is stable low during the high period of the clock tap. When the master is transmitting to MMA7660FC, it generates the acknowledge bit because it is the recipient. When the device is transmitting to the master, the master generates the acknowledge bit because the master is the recipient.

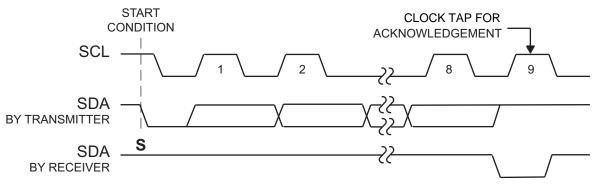


Figure 10. Acknowledge

#### The Slave Address

<u>MMA7660FC</u> has a 7-bit long slave address, shown in Figure 11. The bit following the 7-bit slave address (bit eight) is the R/W bit, which is low for a write command and high for a read command. The device has a factory set  $I^2C$  slave address which is normally 1001100 (0x4C). Contact the factory to request a different  $I^2C$  slave address, which is available in the range 0001000 to 1110111 (0x08 to 0xEF), by metal mask option.

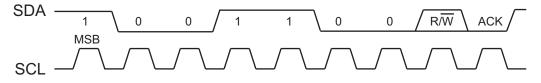


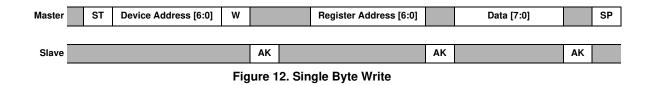
Figure 11. Slave Address

The device monitors the bus continuously, waiting for a START condition followed by its slave address. When the device recognizes its slave address, it acknowledges and is then ready for continued communication.

#### Message Format for Writing MMA7660FC

A write to MMA7660FC comprises the transmission of the device's keyscan slave address with the R/W bit set to 0, followed by at least one byte of information. The first byte of information is the register address of the first internal register that is to be updated. The Master Write address is 1001 1000 (0x98). If a STOP condition is detected after just the register address is received, then MMA7660FC takes no action. See Figure 12. MMA7660FC clears its internal register address pointer to register 0x00 when a STOP condition is detected, so a single byte write has no net effect because the register address given in this first and only byte is replaced by 0x00 at the STOP condition. The internal register address pointer is *not*, however, cleared on a repeated start condition. Use a single byte write followed by a repeated start to read back data from a register.

Any bytes received after the register address are data bytes. The first data byte goes into the internal register of the device selected by the register address. See Figure 12.





If multiple data bytes are transmitted before a STOP condition is detected, these bytes are generally stored in subsequent MMA7660FC internal registers because the register address generally auto-increments.

| Master | ST | Device Address [6:0] | W |    | Register Address [6:0] | Data [7:0] |    | Data [7:0] |    | SP |
|--------|----|----------------------|---|----|------------------------|------------|----|------------|----|----|
| _      |    |                      |   |    |                        |            |    |            |    |    |
| Slave  |    |                      |   | AK | AK                     |            | AK |            | AK |    |

Figure 13. Multiple Bytes Write

#### Message Format for Reading MMA7660FC

MMA7660FC is read using it's internally stored register address as address pointer, the same way the stored register address is used as address pointer for a write. The pointer generally auto-increments after each data byte is read using the same rules as for a write. Thus, a read is initiated by first configuring the device's register address by performing a write (Figure 12) followed by a repeated start. The Master Write address is 1001 1001 (0x99). The master can now read 'n' consecutive bytes from it, with the first data byte being read from the register addressed by the initialized register address.

| Master | ST  | Devic   | e Addı  | ress [6:0] | w   |    | Regist     | er Address [ | [6:0]   | SI   | R De | evice Address [6:0] | R  |    |            | NAK | SP |
|--------|-----|---------|---------|------------|-----|----|------------|--------------|---------|------|------|---------------------|----|----|------------|-----|----|
| Slave  |     |         |         |            |     | AK |            |              | Α       | к    |      |                     |    | AK | Data [7:0] |     |    |
|        |     |         |         |            |     | ,  | E i a      |              |         |      | Dee  | - 4                 |    |    | 2446 [110] |     |    |
|        |     |         |         |            |     |    | Fig        | ure 14. Si   | ngie i  | syte | Rea  | 10                  |    |    |            |     |    |
| Master |     | T Dev   | vice Ad | dress [6:0 | ı w |    | Bog        | ister Addres | n [6·0] |      | SR   | Device Address [6:  | 01 | R  |            |     | AK |
| Master |     |         | ice Au  |            | 1 1 |    | neg        | Istel Addres | 5 [0.0] |      | 31   | Device Address [0.  | 0] | n  |            |     | AN |
| Slave  |     |         |         |            |     | AK |            |              |         | AK   |      |                     |    | AK | Data [7:0] |     |    |
|        |     |         |         |            |     |    |            |              |         |      |      |                     |    |    |            |     |    |
| Master |     |         | AK      |            |     | AK |            | NAK SP       | ]       |      |      |                     |    |    |            |     |    |
|        |     |         |         |            |     |    |            |              | _       |      |      |                     |    |    |            |     |    |
| Slave  | Dat | a [7:0] |         | Data [7:   | :0] |    | Data [7:0] |              |         |      |      |                     |    |    |            |     |    |
|        |     |         |         |            |     |    | Figu       | ro 15 Mul    | ltinla  | Rvto |      | aad                 |    |    |            |     |    |

Figure 15. Multiple Bytes Read



## **APPENDIX A – PACKAGE REQUIREMENTS FOR MMA7660FC**

#### Minimum Recommended Footprint for Surface Mounted Applications

Surface mount board layout is a critical portion of the total design. The footprint for the surface mount packages must be the correct size to ensure proper solder connection interface between the board and the package. With the correct footprint, the packages will self-align when subjected to a solder reflow process. It is always recommended to design boards with a solder mask layer to avoid bridging and shorting between solder pads.

#### Soldering And Mounting Guidelines for the DFN Accelerometer Sensor to a PC Board

These guidelines are for soldering and mounting the Dual Flat No-Lead (DFN) package inertial sensors to printed circuit boards (PCBs). The purpose is to minimize the stress on the package after board mounting. The MMA7660 digital output accelerometer uses the DFN package platform. This section describes suggested methods of soldering these devices to the PC board for consumer applications. Pages 31, 32, and 33 show the package outline drawing for the package.

#### **Overview of Soldering Considerations**

Information provided here is based on experiments executed on DFN devices. They do not represent exact conditions present at a customer site. Hence, information herein should be used as guidance only and process and design optimizations are recommended to develop an application specific solution. It should be noted that with the proper PCB footprint and solder stencil designs the package will self-align during the solder reflow process. The following are the recommended guidelines to follow for mounting DFN sensors for consumer applications.

#### Halogen Content

This package is designed to be Halogen Free, exceeding most industry and customer standards. Halogen Free means that no homogeneous material within the assembly package shall contain chlorine (CI) in excess of 700 ppm or 0.07% weight/weight or bromine (Br) in excess of 900 ppm or 0.09% weight/weight.

Note: Halogen Free is only compliant to the MMA7660FC, not to the packaging material.

#### **PCB Mounting Recommendations**

- 1. The PCB land should be designed with Non Solder Mask Defined (NSMD) as shown in Figure 16 and Figure 17.
- 2. No additional via pattern underneath package.
- 3. PCB land pad is 0.825 mm x 0.3 mm as shown in Figure 16 and Figure 17.
- 4. Do not solder down smaller side tabs on either end of the package.
- 5. The solder mask opening is equal to the size of the PCB land pad plus 0.15 mm.
- 6. The stencil aperture size is equal to the PCB land pad minus 0.03 mm total.
- 7. Stencil thickness should be 75 μm.
- Do not place any components or vias at a distance less than 2 mm from the package land area. This may cause additional
  package stress if it is too close to the package land area.
- 9. Signal traces connected to pads should be as symmetric as possible. Put dummy traces on NC pads in order to have same length of exposed trace for all pads. Signal traces with 0.15 mm width and minimum 0.5 mm length for all PCB land pads near the package are recommended as shown in Figure 16 and Figure 17. Wider trace can be continued after the 0.5 mm zone.
- 10. Use a standard pick and place process and equipment. Do not use a hand soldering process.
- 11. It is recommended to use a no clean solder paste.
- 12. Do not use a screw down or stacking to fix the PCB into an enclosure because this could bend the PCB putting stress on the package.
- 13. The PCB should be rated for the multiple lead-free reflow condition with max 260°C temperature.
- 14. No copper traces on top layer of PCB under the package. This will cause planarity issues with board mount.

Freescale DFN sensors are compliant with Restrictions on Hazardous Substances (RoHS), having halide free molding compound (green) and lead-free terminations. These terminations are compatible with tin-lead (Sn-Pb) as well as tin-silver-copper (Sn-Ag-Cu) solder paste soldering processes. Reflow profiles applicable to those processes can be used successfully for soldering the devices.

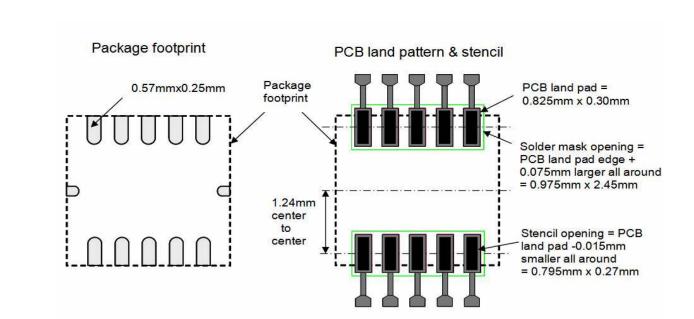


Figure 16. Package Footprint, PCB Land Pattern, and Stencil Design

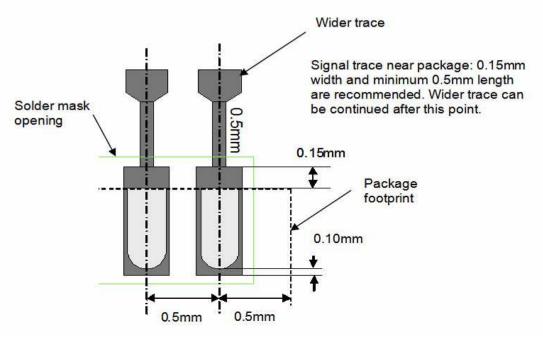


Figure 17. PCB Land Pattern Detail



## **APPENDIX B - SENSING DIRECTION**

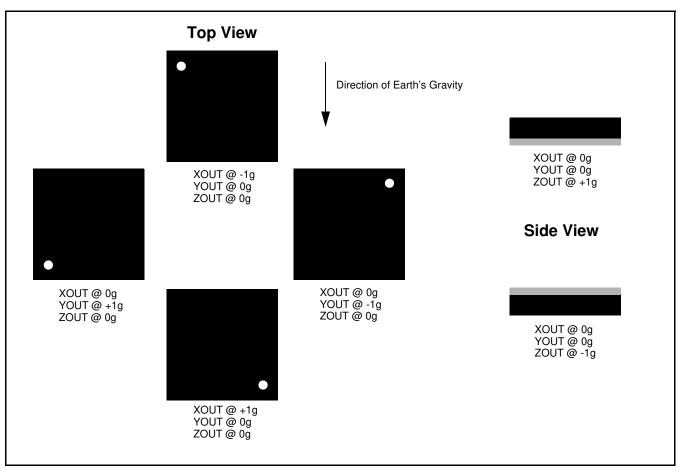
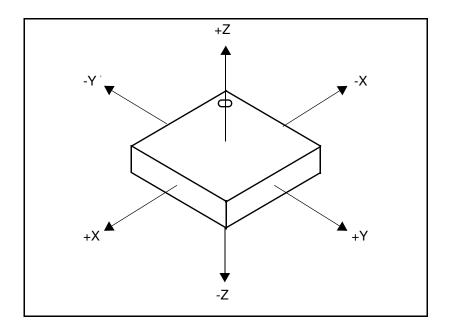


Figure 18. Product Orientation on Perpendicular Axis







## APPENDIX C - MMA7660FC ACQUISITION CODE TABLE

| 0      |   |   |  |   |  |
|--------|---|---|--|---|--|
| 0      | 0   | 0.000g  | 0.00°  |   | 90.00°   |
| 1      | 1   | 0.047g  | 2.69°  |   | 87.31°   |
| 10     | 2   | 0.094g  | 5.38°  |   | 84.62°   |
| 11     | 3   | 0.141g  | 8.08°  |   | 81.92°   |
| 100    | 4   | 0.188g  | 10.81°   |   | 79.19°   |
| 101    | 5   | -   | 13.55°   |   | 76.45°   |
| 110    | 6   | -   | 16.33°   |   | 73.67°   |
| 111    | 7   | 0.328g  | 19.16°   |   | 70.84°   |
| 1000   | 8   | 0.375g  | 22.02°   |   | 67.98°   |
| 1001   | 9   | 0.422g  | 24.95°   |   | 65.05°   |
| 1010   | 10  | 0.469g  | 27.95°   |   | 62.05°   |
| 1011   | 11  | 0.516g  | 31.04°   |   | 58.96°   |
| 1100   | 12  | 0.563g  | 34.23°   | Ð   | 55.77°   |
| 1101   | 13  | 0.609g  | 37.54°   | ang   | 52.46°   |
| 1110   | 14  | 0.656g  | 41.01°   | her   | 48.99°   |
|        | 15  | _   |  | in t  | 45.32°   |
|        | 16  | -   |  | t be  | 41.41°   |
|        |   | _   |  | snu   | 37.17°   |
|        |   | -   |  | xis r   | 32.46°   |
|        | -   |   |  | Z-a   | 27.05°   |
|        |   | -   |  |   | 20.36°   |
|        |   | _   | 79.86°   |   | 10.14°   |
|        |   | -   |  |   |  |
|        |   | -   |  |   |  |
|        |   | -   |  |   |  |
|        |   | -   |  |   |  |
|        |   | -   |  |   |  |
|        | 28  | -   | Shaken   |   |  |
|        |   | -   |  |   |  |
|        |   |   |  |   |  |
|        |   | <u> </u>  |  |   |  |
|        |   | -   |  |   | 07.010   |
|        |   |   |  |   | -87.31°  |
|        |   | , v   |  |   | -84.62°  |
|        | -3  | -   |  |   | -81.92°  |
| 111100 | -4  | -0.188g   | -10.81°  |   | -79.19°  |
| 111011 | -5  | -0.234g   | -13.55°  |   | -76.45°  |
| 111010 | -6  | -0.281g   | -16.33°  |   | -73.67°  |
| 111001 | -7  | -0.328g   | -19.16°  |   | -70.84°  |
| 111000 | -8  | -0.375g   | -22.02°  |   | -67.98°  |
| 110111 | -9  | -0.422g   | -24.95°  |   | -65.05°  |
| 110110 | -10   | -0.469g   | -27.95°  |   | -62.05°  |
|        | -11   | -0.516g   | -31.04°  |   | -58.96°  |
|        |   | , v   |  |   | -55.77°  |
|        |   | -   |  |   | -52.46°  |
|        |   | -   |  |   | -32.46<br>-48.99°  |
|        | 10<br>11<br>100<br>101<br>110<br>110<br>110<br>110<br>1 | 10211310041015110611171000810019101010101111110012110113111014111115100001610011171000016100011710010181001119101002010101211010221011123110002411001251101026110112711100281110129111103011111-111110-211110-311110-411101-711100-811011-711000-8110111-10110101-11110101-11110101-12110111-13 | 10         2         0.094g           11         3         0.141g           100         4         0.188g           101         5         0.234g           110         6         0.281g           111         7         0.328g           1000         8         0.375g           1001         9         0.422g           1010         10         0.469g           1011         11         0.516g           1100         12         0.563g           1101         13         0.609g           1111         15         0.703g           10001         17         0.797g           10001         18         0.844g           10011         19         0.891g           10100         20         0.938g           10101         21         0.984g           10111         23         1.078g           11000         24         1.125g           11001         25         1.172g           11001         26         1.219g           11010         28         1.313g           11101         29         1.359g | 10         2         0.094g         5.38°           11         3         0.141g         8.08°           100         4         0.188g         10.81°           101         5         0.234g         13.55°           110         6         0.281g         16.33°           111         7         0.328g         19.16°           1000         8         0.375g         22.02°           1001         9         0.422g         24.95°           1010         10         0.469g         27.95°           1011         11         0.516g         31.04°           1100         12         0.563g         34.23°           1101         13         0.609g         37.54°           1110         14         0.656g         41.01°           1111         15         0.703g         44.68°           10001         17         0.797g         52.83°           10001         17         0.797g         52.83°           10010         20         0.938g         69.64°           10101         21         0.984g         79.86°           10101         25         1.172g         1 | 10         2         0.094g         5.38°           11         3         0.141g         8.08°           100         4         0.188g         10.81°           101         5         0.234g         13.55°           110         6         0.281g         16.33°           111         7         0.328g         19.16°           1000         8         0.375g         22.02°           1001         9         0.422g         24.95°           1010         10         0.469g         27.95°           1011         11         0.516g         31.04°           1100         12         0.563g         34.23°           1110         14         0.656g         41.01°           1111         15         0.730g         44.68°           10001         17         0.797g         52.83°           10001         18         0.844g         57.54°           10011         21         0.984g         79.86°           10100         22         1.031g         10101           10101         25         1.172g         10101           10101         25         1.125g         11101 |



| 49 | 110001 | -15 | -0.703g | -44.68° | -45.32° |
|----|--------|-----|---------|---------|---------|
| 48 | 110000 | -16 | -0.750g | -48.59° | -41.41° |
| 47 | 101111 | -17 | -0.797g | -52.83° | -37.17° |
| 46 | 101110 | -18 | -0.844g | -57.54° | -32.46° |
| 45 | 101101 | -19 | -0.891g | -62.95° | -27.05° |
| 44 | 101100 | -20 | -0.938g | -69.64° | -20.36° |
| 43 | 101011 | -21 | -0.984g | -79.86° | -10.14° |
| 42 | 101010 | -22 | -1.031g |         |         |
| 41 | 101001 | -23 | -1.078g |         |         |
| 40 | 101000 | -24 | -1.125g |         |         |
| 39 | 100111 | -25 | -1.172g |         |         |
| 38 | 100110 | -26 | -1.219g |         |         |
| 37 | 100101 | -27 | -1.266g |         |         |
| 36 | 100100 | -28 | -1.313g | Shaken  |         |
| 35 | 100011 | -29 | -1.359g | Shaken  |         |
| 34 | 100010 | -30 | -1.406g | Shaken  |         |
| 33 | 100001 | -31 | -1.453g | Shaken  |         |
| 32 | 100000 | -32 | -1.500g | Shaken  |         |

## APPENDIX C - MMA7660FC ACQUISITION CODE TABLE, continued

## APPENDIX D - I<sup>2</sup>C AC CHARACTERISTICS

This section includes information about I<sup>2</sup>C AC Characteristics.

### Table 1. I<sup>2</sup>C AC Characteristics

(Typical Operating Circuit,  $V_{DD}$  = 1.71 V to 2.75 V,  $T_A$  =  $T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted. Typical current values are at  $V_{DD}$  = 1.8 V,  $T_A$  = +25°C.)

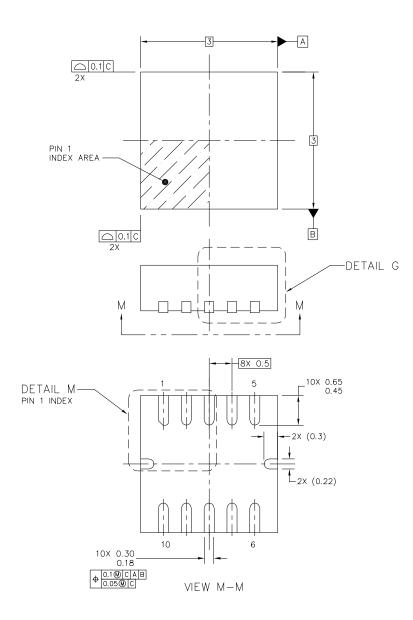
| Parameter   | Symbol               | Min | Тур                  | Max | Units |
|---|----------------------|-----|----------------------|-----|-------|
| Serial Clock Frequency <sup>(1)</sup>                             | f <sub>SCL</sub>     |     |                      | 400 | kHz   |
| Bus Free Time Between a STOP and a START Condition <sup>(2)</sup> | t <sub>BUF</sub>     | 1.3 |                      |     | μs    |
| Hold Time, (Repeated) START Condition <sup>(2)</sup>              | t <sub>HD, STA</sub> | 0.6 |                      |     | μs    |
| Repeated START Condition Setup Time <sup>(2)</sup>                | t <sub>SU, STA</sub> | 0.6 |                      |     | μs    |
| STOP Condition Setup Time <sup>(2)</sup>                          | t <sub>SU, STO</sub> | 0.6 |                      |     | μs    |
| Data Hold Time <sup>(2)</sup>                                     | t <sub>hd, dat</sub> |     |                      | 0.9 | μs    |
| Data Setup Time <sup>(2)</sup>                                    | t <sub>SU, DAT</sub> | 100 |                      |     | ns    |
| SCL Clock Low Period <sup>(2)</sup>                               | t <sub>LOW</sub>     | 1.3 |                      |     | μs    |
| SCL Clock High Period <sup>(2)</sup>                              | t <sub>HIGH</sub>    | 0.7 |                      |     | μs    |
| Rise Time of Both SDA and SCL Signals, Receiving <sup>(2)</sup>   | t <sub>R</sub>       |     | 20+0.1C <sub>b</sub> | 300 | ns    |
| Fall Time of Both SDA and SCL Signals, Receiving <sup>(2)</sup>   | t <sub>F</sub>       |     | 20+0.1C <sub>b</sub> | 300 | ns    |
| Fall Time of SDA Transmitting <sup>(2)</sup>                      | t <sub>F.TX</sub>    |     | 20+0.1C <sub>b</sub> | 250 | ns    |
| Pulse Width of Spike Suppressed <sup>(2)</sup>                    | t <sub>SP</sub>      |     | 25                   |     | ns    |
| Capacitive Load for Each Bus Line <sup>(2)</sup>                  | Cb                   |     |                      | 400 | pF    |

1. Parameters tested 100% at final test at room temperature; limits at -40°C and +85°C, verified by characterization, not test in production.

2. Limits verified by characterization, not tested in production.



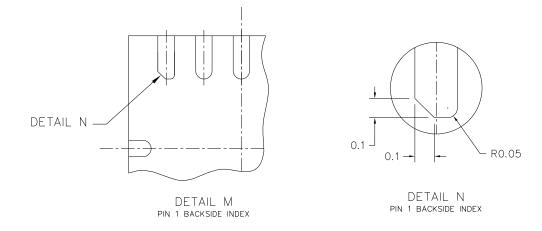
## PACKAGE DIMENSIONS

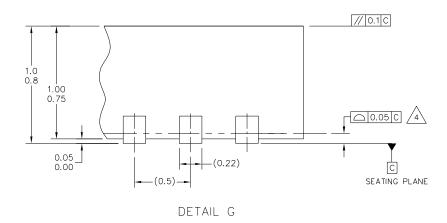


| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED. | MECHANICA                      | LOUTLINE     | PRINT VERSION NO | T TO SCALE |
|---|--------------------------------|--------------|------------------|------------|
| TITLE: DUAL FLAT NO LEA                                 |                                | DOCUMENT NO  | ): 98ASA10816D   | REV: B     |
| COL PACKAGE (DFN-0                                      | CASE NUMBER: 2002-03 14 AUG 20 |              |                  |            |
| 10 TERMINAL, 0.5 PITCH (3                               | X 3 X 0.9)                     | STANDARD: NO | N JEDEC          |            |



## PACKAGE DIMENSIONS





| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED. | MECHANICA  | L OUTLINE    | PRINT VERSION NO | T TO SCALE  |
|---|------------|--------------|------------------|-------------|
| TITLE: DUAL FLAT NO LEA                                 | D          | DOCUMENT NO  | REV: B           |             |
| COL PACKAGE (DFN-C                                      |            | CASE NUMBER  | : 2002-03        | 14 AUG 2008 |
| 10 TERMINAL, 0.5 PITCH (3 )                             | X 3 X 0.9) | STANDARD: NO | N JEDEC          |             |



## PACKAGE DIMENSIONS

NOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS.

2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.

- 3. THIS IS NON JEDEC REGISTERED PACKAGE.
- 4. COPLANARITY APPLIES TO LEADS AND ALL OTHR BOTTOM SURFACE METALLIZATION.
- 5. MIN. METAL GAP SHOULD BE 0.2MM.

| © FREESCALE SEMICONDUCTOR, INC.<br>ALL RIGHTS RESERVED. | MECHANICA                       | LOUTLINE     | PRINT VERSION NO | T TO SCALE |
|---|---------------------------------|--------------|------------------|------------|
| TITLE: DUAL FLAT NO LEA                                 | D                               | DOCUMENT NO  | REV: B           |            |
| COL PACKAGE (DFN-0                                      | CASE NUMBER: 2002-03 14 AUG 200 |              |                  |            |
| 10 TERMINAL, 0.5 PITCH (3                               | X 3 X 0.9)                      | STANDARD: NO | ON JEDEC         |            |



## Table 2. Revision History

| Revision<br>number | Revision<br>date | Description of changes  |
|--------------------|------------------|---|
| 9                  | 03/2012          | <ul> <li>Changed pin 10 from N/C to RESERVED on page 1, Figure 1, Figure 2 and Table 1: Pin<br/>description.</li> </ul> |



## How to Reach Us:

Home Page: www.freescale.com

Web Support: http://www.freescale.com/support

#### USA/Europe or Locations Not Listed:

Freescale Semiconductor, Inc. Technical Information Center, EL516 2100 East Elliot Road Tempe, Arizona 85284 1-800-521-6274 or +1-480-768-2130 www.freescale.com/support

#### Europe, Middle East, and Africa:

Freescale Halbleiter Deutschland GmbH Technical Information Center Schatzbogen 7 81829 Muenchen, Germany +44 1296 380 456 (English) +46 8 52200080 (English) +49 89 92103 559 (German) +33 1 69 35 48 48 (French) www.freescale.com/support

#### Japan:

Freescale Semiconductor Japan Ltd. Headquarters ARCO Tower 15F 1-8-1, Shimo-Meguro, Meguro-ku, Tokyo 153-0064 Japan 0120 191014 or +81 3 5437 9125 support.japan@freescale.com

#### Asia/Pacific:

Freescale Semiconductor China Ltd. Exchange Building 23F No. 118 Jianguo Road Chaoyang District Beijing 100022 China +86 010 5879 8000 support.asia@freescale.com

#### For Literature Requests Only:

Freescale Semiconductor Literature Distribution Center 1-800-441-2447 or +1-303-675-2140 Fax: +1-303-675-2150 LDCForFreescaleSemiconductor@hibbertgroup.com Information in this document is provided solely to enable system and software implementers to use Freescale Semiconductor products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Freescale Semiconductor reserves the right to make changes without further notice to any products herein. Freescale Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals", must be validated for each customer application by customer's technical experts. Freescale Semiconductor does not convey any license under its patent rights nor the rights of others. Freescale Semiconductor products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Freescale Semiconductor product could create a situation where personal injury or death may occur. Should Buyer purchase or use Freescale Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold Freescale Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Freescale Semiconductor was negligent regarding the design or manufacture of the part.

Freescale and the Freescale logo are trademarks of Freescale Semiconductor, Inc., Reg. U.S. Pat. & Tm. Off. Xtrinsic is a trademark of Freescale Semiconductor, Inc. All other product or service names are the property of their respective owners. © 2012 Freescale Semiconductor, Inc. All rights reserved.

RoHS-compliant and/or Pb-free versions of Freescale products have the functionality and electrical characteristics of their non-RoHS-compliant and/or non-Pb-free counterparts. For further information, see http://www.freescale.com or contact your Freescale sales representative.

For information on Freescale's Environmental Products program, go to http://www.freescale.com/epp.



MMA7660FC Rev. 8 03/2012